

Search Notes

Application/Control No.

10/776,259

Examiner

Le Nguyen

Applicant(s)/Patent under
Reexamination

TAGUCHI, TERUTOSHI

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	763	1/25/2007	LVN
345	420	1/25/2007	LVN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
US-PG Pub, USPAT: 715/763, 345/420		1/25/2007	LVN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PG Pub, USPAT: 715/502,964,763; 345/419,420	1/25/2007	LVN
consulted w/Ba Huynh	1/25/2007	LVN
inventor name search	1/25/2007	LVN
consulted w/QAS, Kakali Chaki	2/16/2007	LVN